

Update on PID studies for ITS upgrade

S.Bufalino, F.Prino

INFN-Torino

and S.Piano

INFN-Trieste

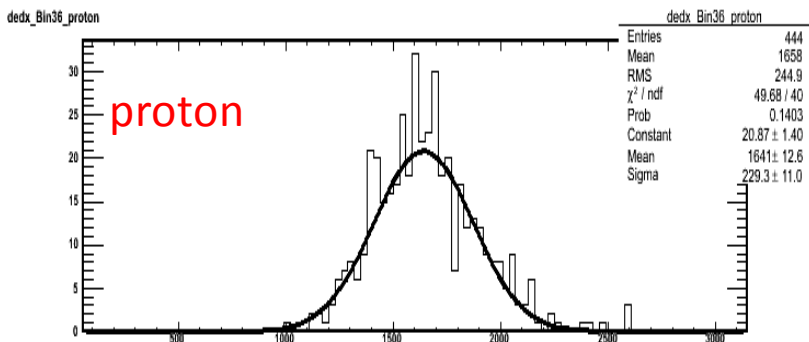
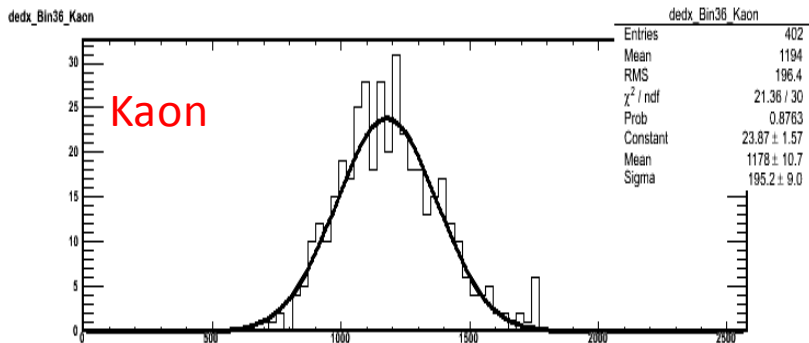
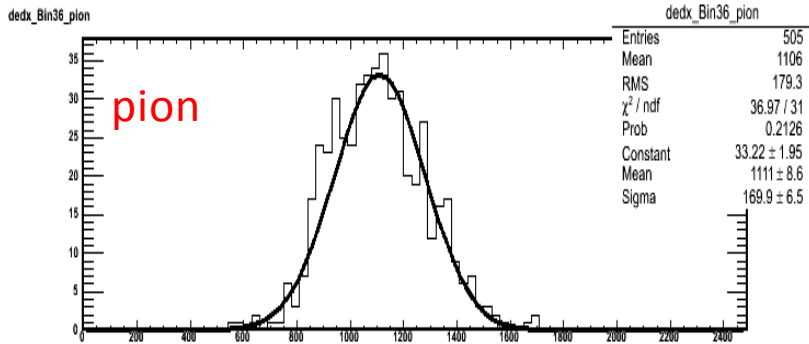
ITS CONFIGURATIONS

“Fast” tool:

ITS with 7 layers: Generated 100K events: π^+ , K^+ , p ($0.040 \text{ GeV}/c < \text{mom} < 2 \text{ GeV}/c$) with relative abundances equal 1/3 for π^+ , K^+ , p

- 7 SPD with different thickness: 10 μm , 15 μm and 18 μm
- Study of the particle separation and ITS resolution for each configuration with different number of ADC bit
- Study of efficiency and contamination for 7 silicon layers of 15 μm using an ADC with 10 bit and three value of noise : 10 e^- , 20 e^- and 40 e^-

Reminder on some definitions



Parametrization for 7 layers

- Fit with a Gaussian function in a momentum bin for each particle type
- 2 x 3 Parameters extracted:
 - Mean value (mv) x π, K, p
 - Gaussian Width (σ) x π, K, p
- Calculation of BetheBloch($\beta\gamma$) parameters by fit of mv values
- Parameterization of $\sigma_{\text{part}}(\beta\gamma)$
- Identity: the lowest $|DE/DX - \text{BetheBloch}(\beta\gamma, M_{\text{part}})| / \sigma_{\text{part}}(\beta\gamma)$

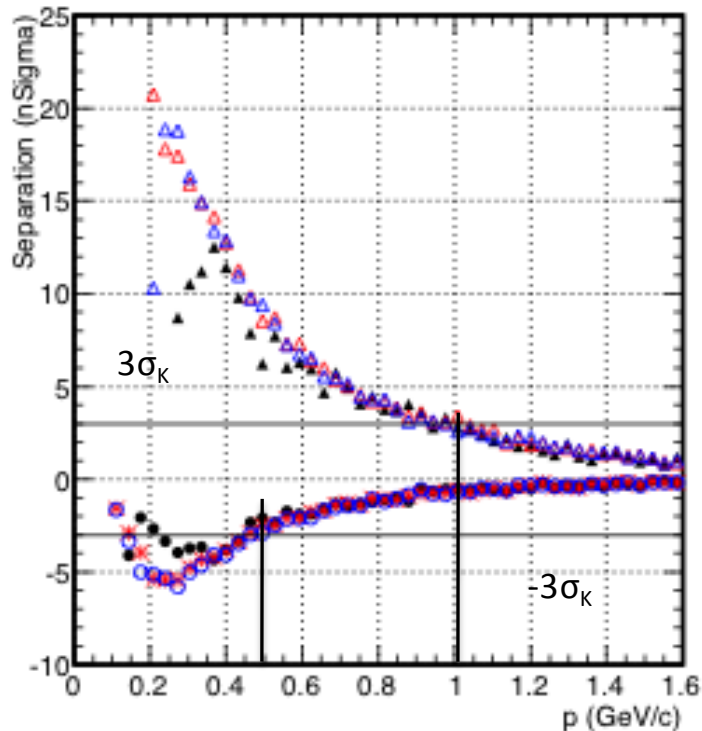
Efficiency = Right MCID/Identity

Contamination =

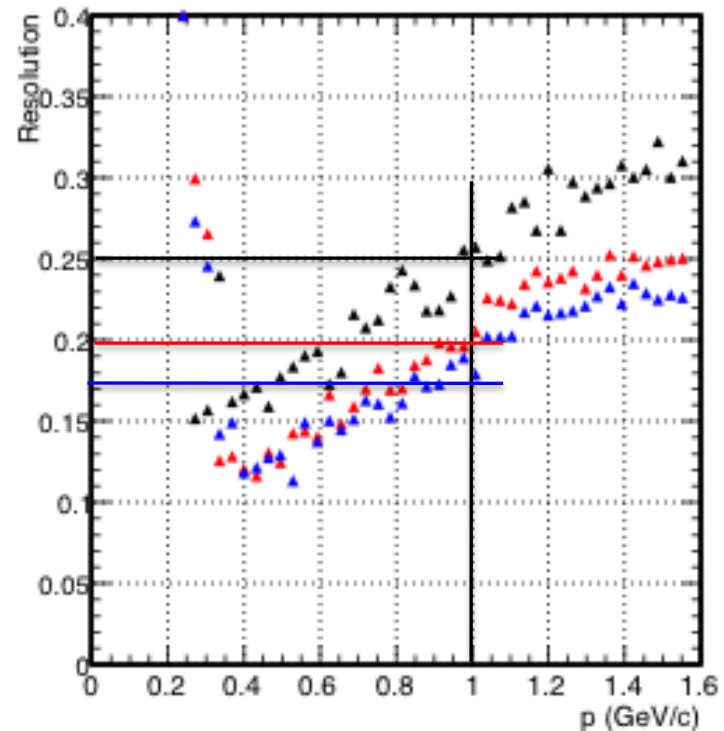
Wrong MCID/(Right MCID+WrongMCID)

7 layer 20 μm for comparison

$$p - K \text{ separation} = (mv_p - mv_K) / \sigma_K$$



Protons



$$\pi - K \text{ separation} = (mv_\pi - mv_K) / \sigma_K$$

$$\text{Resolution} = \sigma_p / mv_p$$

Particle mix: abundances equal to 1/3 for π^+ , K^+ , p

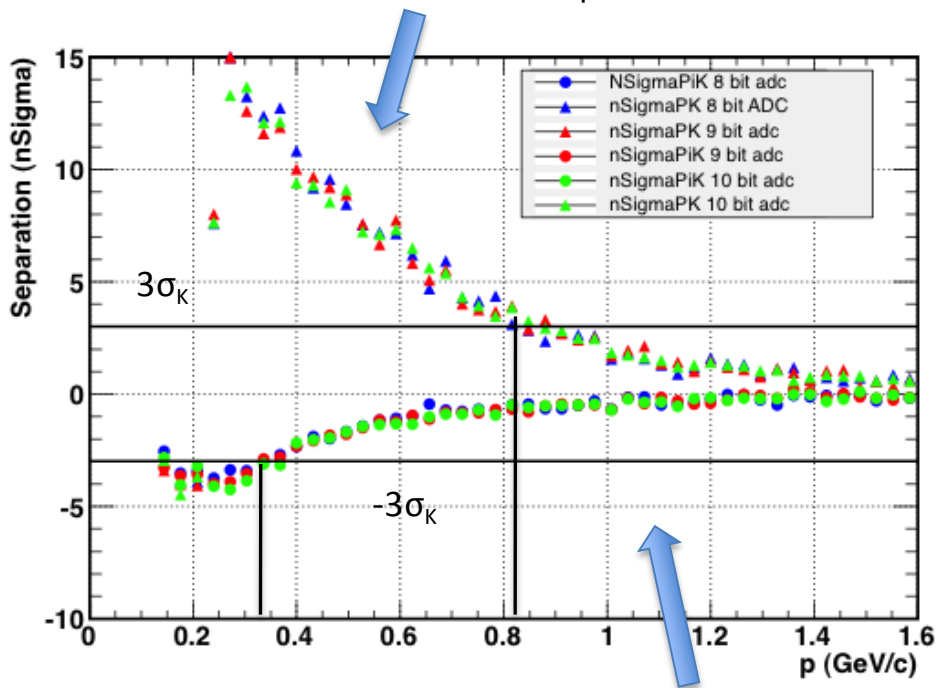
Blue 8 bit ADC

Red 6 bit ADC

Black 4 bit ADC

nSigma separation and resolution for 7 layers of 10 μm

$$p - K \text{ separation} = (mv_p - mv_K) / \sigma_K$$

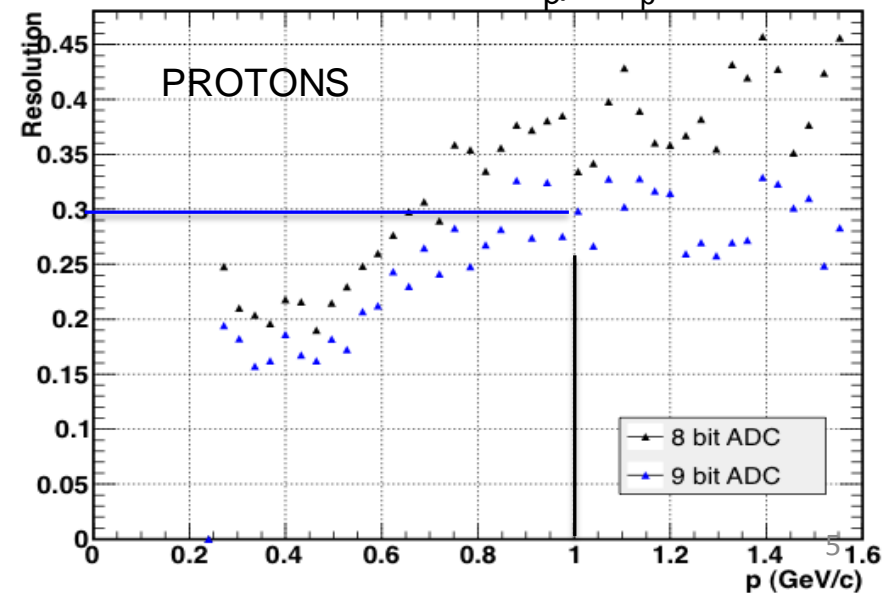
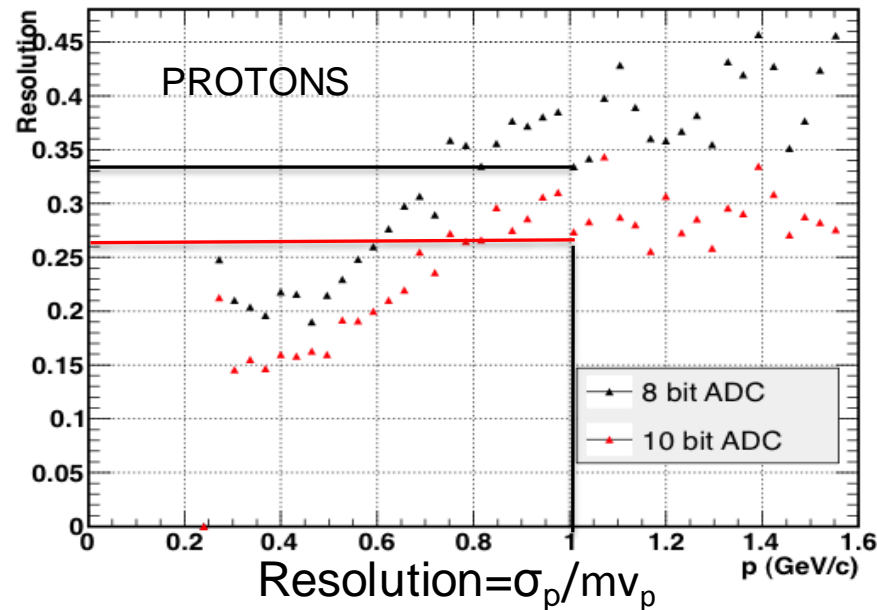


$$\pi - K \text{ separation} = (mv_\pi - mv_K) / \sigma_K$$

Particle mix:

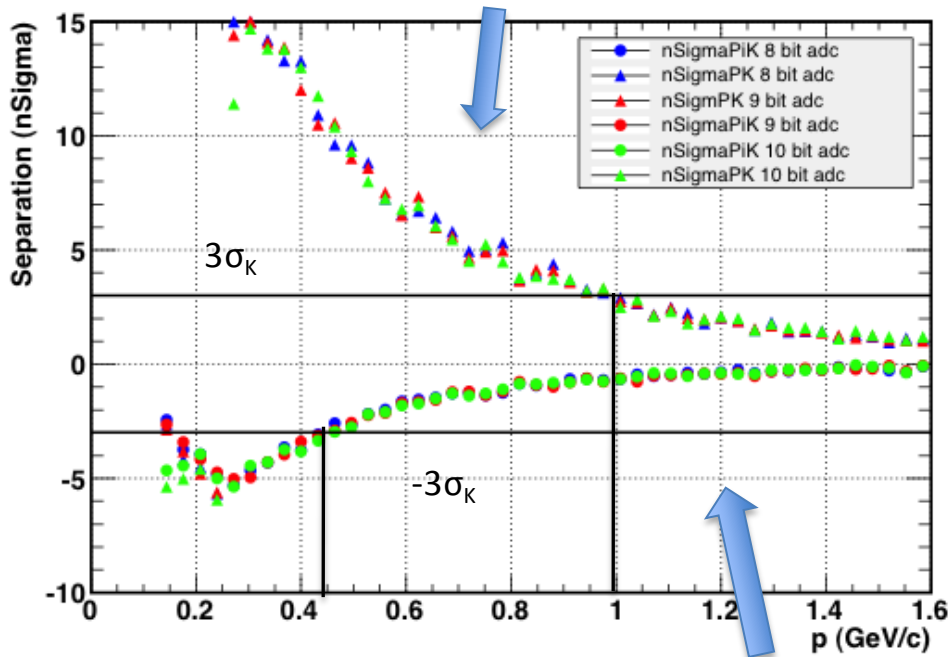
Abundances equal to 1/3 for π⁺, K⁺, p

Noise gaussian distributed of 20 e⁻



nSigma separation and resolution for 7 layers of 15 μm

$$\rho - K \text{ separation} = (mv_{\rho} - mv_K) / \sigma_K$$

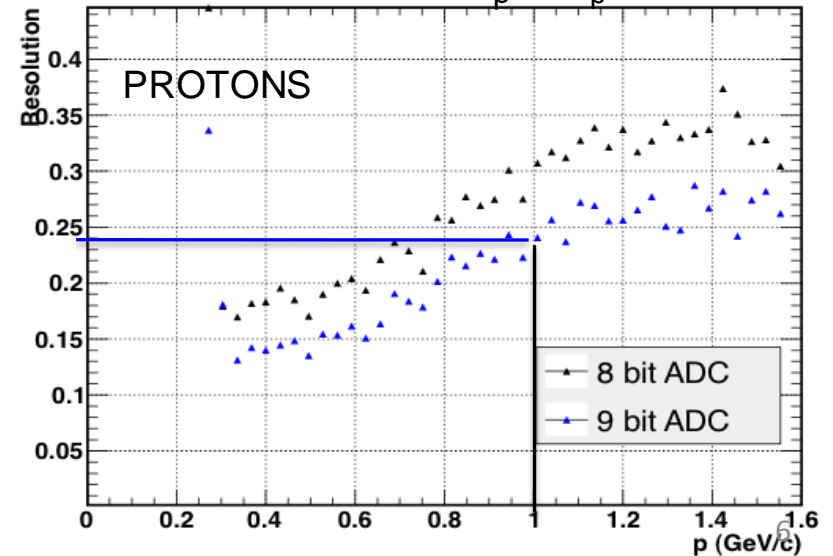
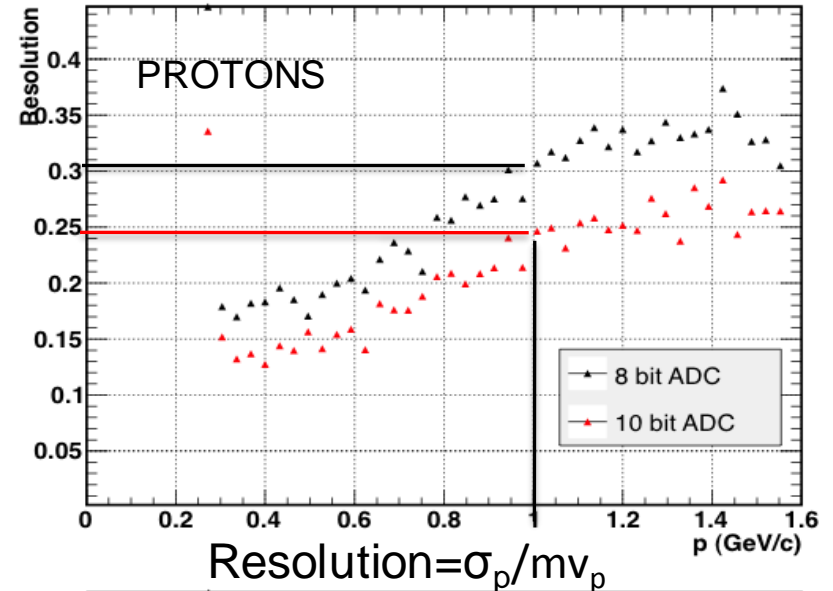


$$\pi - K \text{ separation} = (mv_{\pi} - mv_K) / \sigma_K$$

Particle mix:

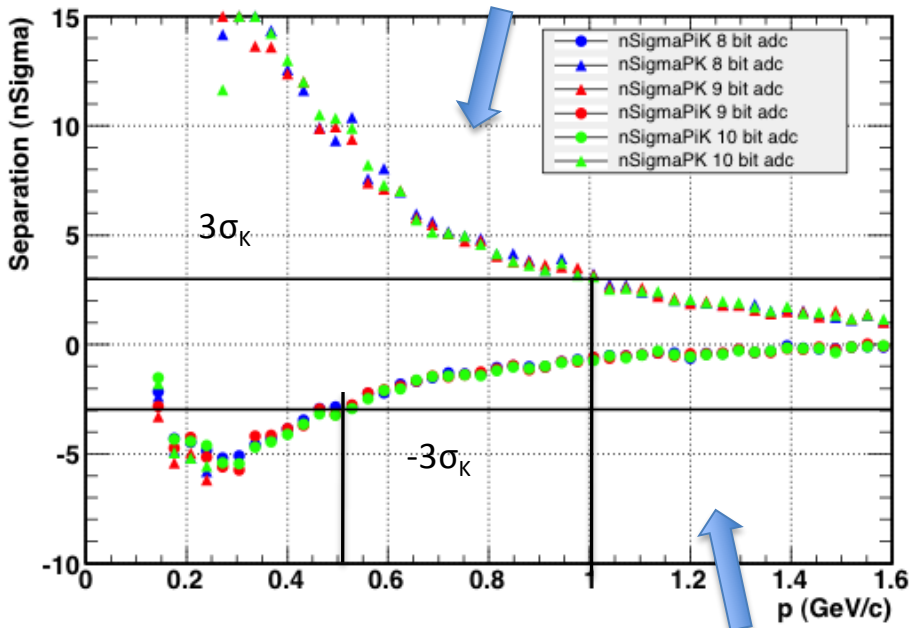
Abundances equal to 1/3 for π^+ , K^+ , p

Noise gaussian distributed of $20 e^-$



nSigma separation and resolution for 7 layers of 18 μm

$$p - K \text{ separation} = (mv_p - mv_K) / \sigma_K$$

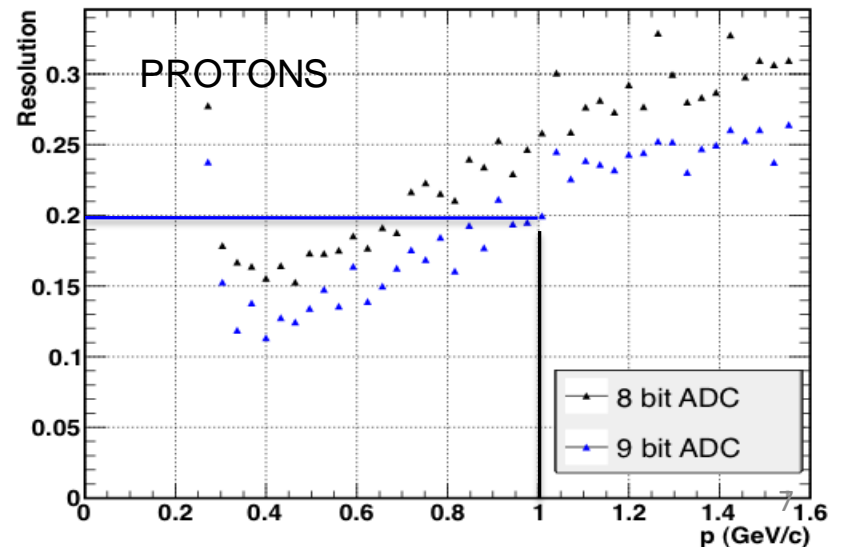
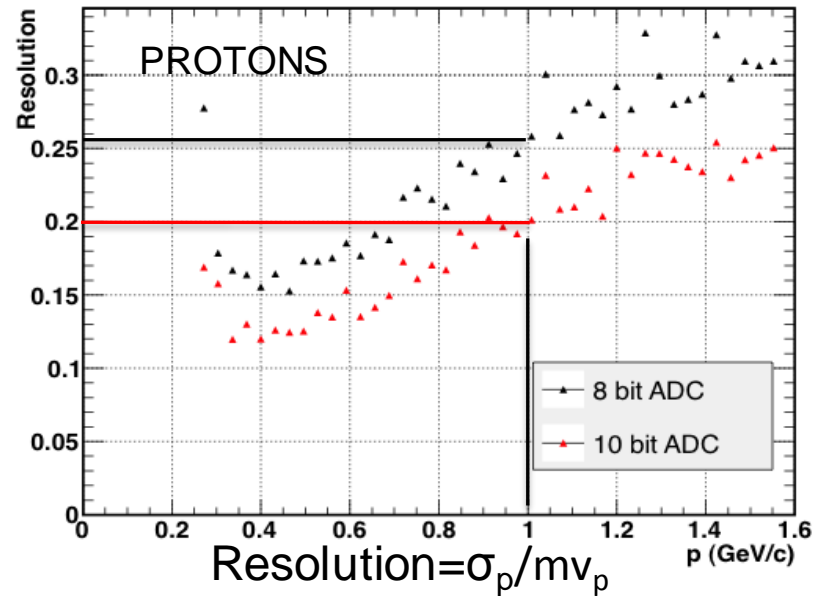


$$\pi - K \text{ separation} = (mv_\pi - mv_K) / \sigma_K$$

Particle mix:

Abundances equal to 1/3 for π^+ , K^+ , p

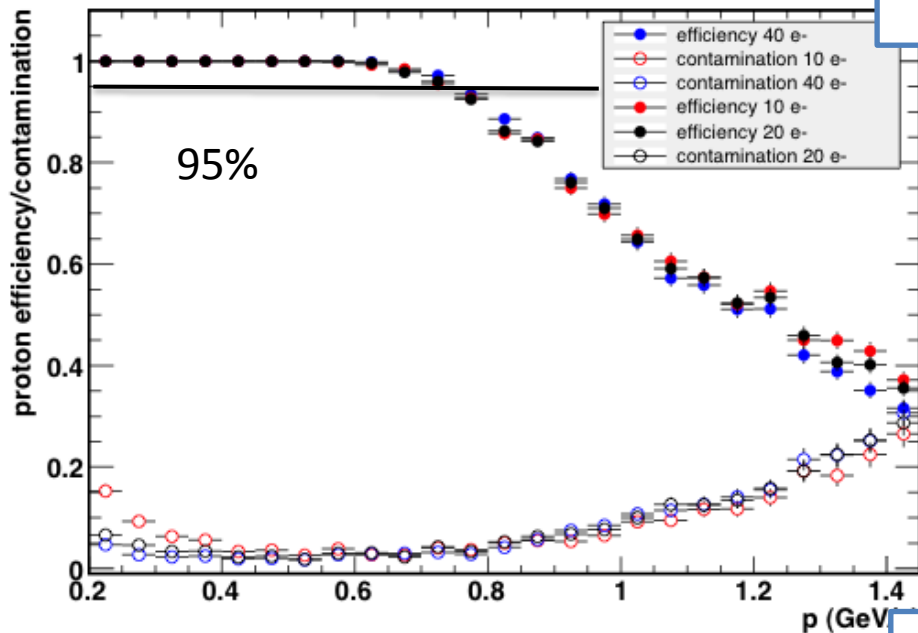
Noise gaussian distributed of $20 e^-$



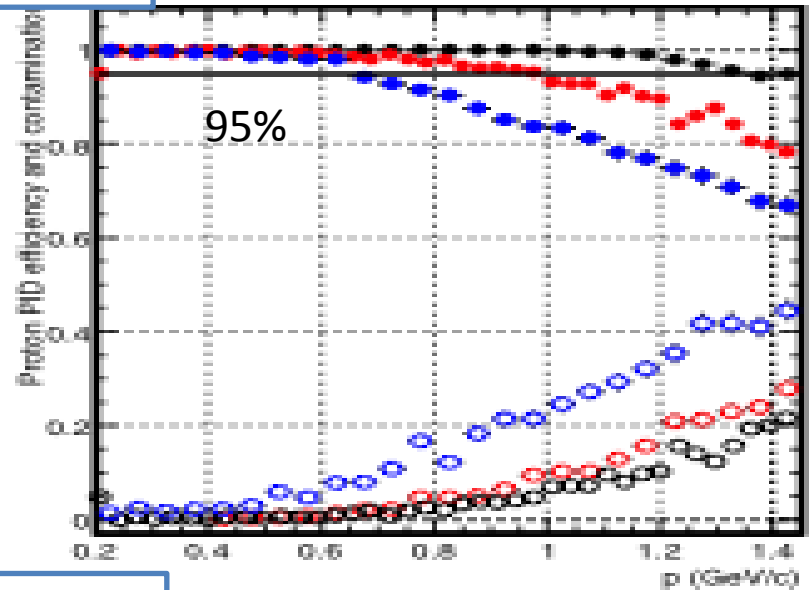
Efficiency and Contamination [15 μm , 10 bit ADC]

PROTON

From chap. 3 of CDR



Efficiency



Contamination

15 μm , 10 bit ADC
Relative abundances=1/3
for π^+ , K^+ , p

Blue symbols: 7 x 20 μm thick
layers with 8 bit ADC

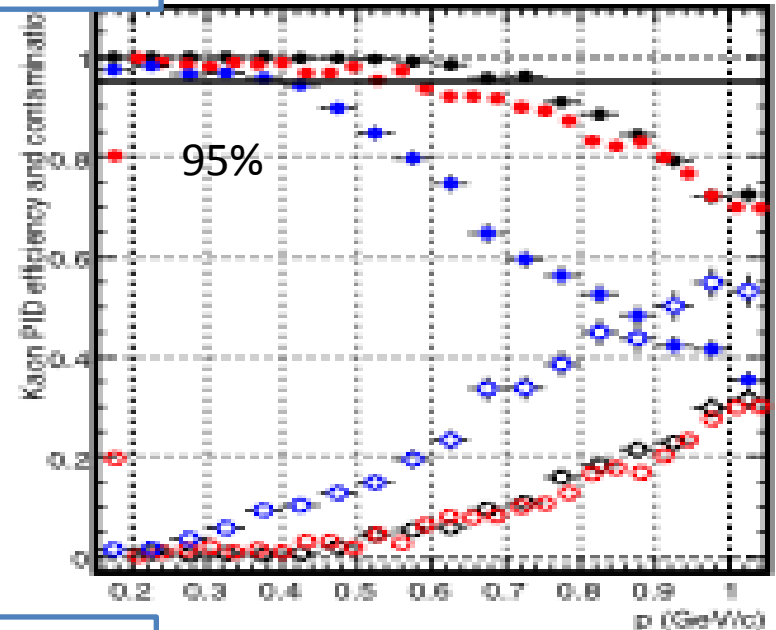
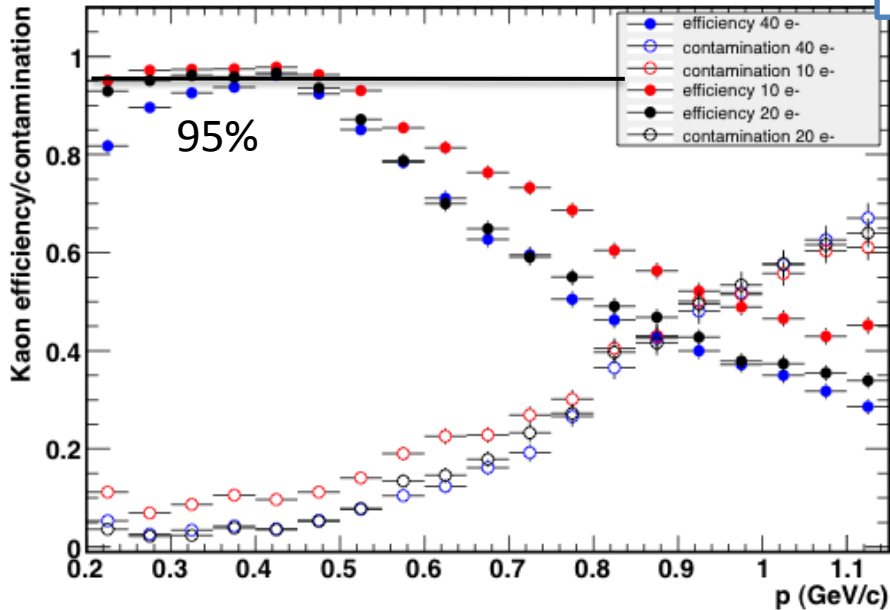
Efficiency and Contamination [15 μm , 10 bit ADC]

KAON

From chap. 3 of CDR

Efficiency

Contamination



15 μm , 10 bit ADC
Relative abundances=1/3
for π^+ , K^+ , p

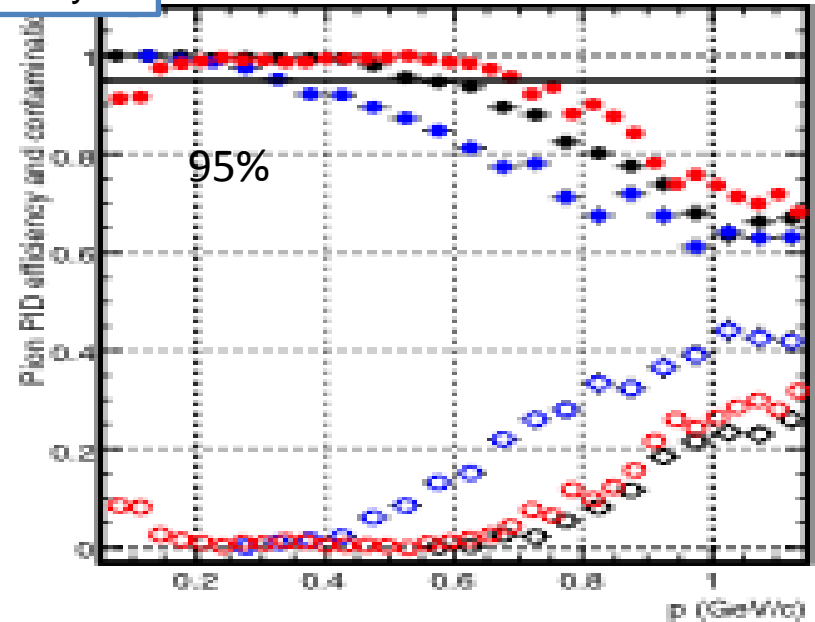
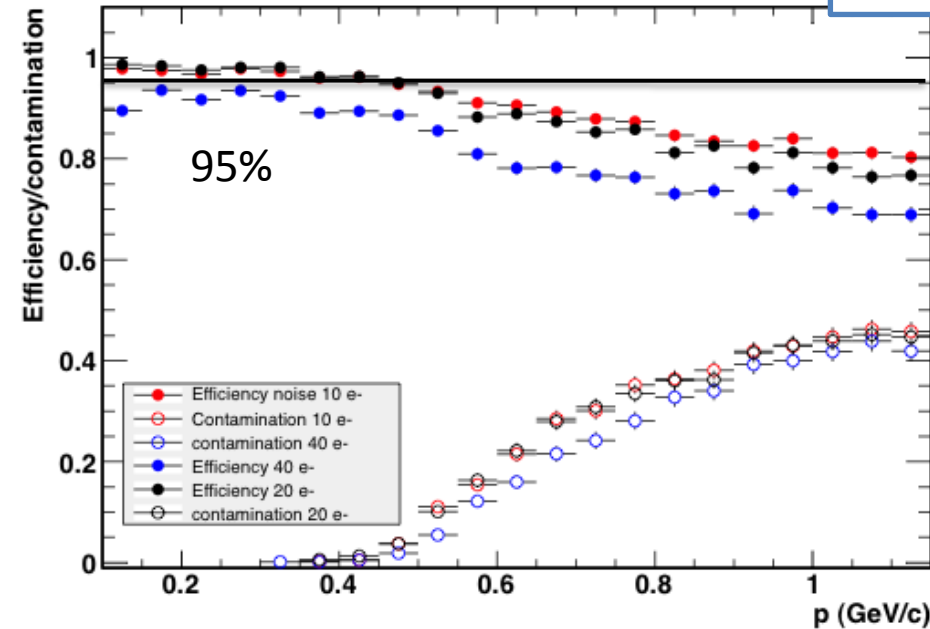
Blue symbols: 7 x 20 μm thick
layers with 8 bit ADC

Efficiency and Contamination [15 μm , 10 bit ADC]

PION

From chap. 3 of CDR

Efficiency



Contamination

15 μm , 10 bit ADC
Relative abundances=1/3
for π^+ , K^+ , p

Blue symbols: 7 x 20 μm thick
layers with 8 bit ADC

...to do

- Study of contamination and efficiency for the ITS configurations with 7 layers of 10 μm and 18 μm
- Generation with particle mixes taken from pp data @ 900 GeV and PbPb data @ 2.76 TeV